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INFORMATION DISCUSUR STATEMENT BY APPLICAN

(Use as many sheets as necessary)

1 of Sheet

	Complete If Known	
Application Number	10/030,317	
Filing Date	October 19, 2001	
First Named Inventor	Alan J. SMITH	
Group Art Unit	Unassigned	
Examiner Name	Unassigned	
Attorney Docket Number	213649	

	U.S. PATENT DOCUMENTS						
		U.S. Patent Document					
Examiner Initials	Doc. No.	Application or Patent Number	Kind Code	Name of Patentee or Applicant	Date of Publication	Filing Date If Appropriate	
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n~:	AL	DE	90 17 745.2	T	Drägerwerk AG	12/7/1990	X	Γ
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		OTHER - NON PATENT LITERATURE DOCUMENTS		lation	
Examiner D	Doc.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item			
Initials No.		(book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number (s), publisher, city and/or country where published.			
5	AP	Anderson et al., "Mirror reflectometer based on optical cavity decay time," Applied Optics, 23:1238-1244 (1984)			
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r~	ΑT	O'Keefe and Deacon, "Cavity ring-down optical spectrometer for absorption measurements using pulsed laser sources," Rev. Sci. Instrum., 59:2544-2551 (1988)			
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Examiner Signature

Date Considered

03

A concise statement of relevance is being submitted in feu of a translation. 37 CFR (1989)(3)

An English-language equivelent/patent, or an English-language abstract, or an English-language version of the search report or action by a foreign patent office in a counterpart foreign application indicating the degree of relevance found by the foreign office is being submitted in lieu of a concise expanation of relevance noted or SFR 1984(3).